

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
	Examiner Michael Trinh	Art Unit 2822	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6114767	09-2000	Nagai et al	257/758
	C	US-5280446	01-1994	Ma et al	257/314
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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